# **VCS Random Testing**

### **Create Test**

2025/09/15 20:01

To create a new test, first open up EDM. On the VCS Start Page, select **Random** under the **Create a test** tab.

EDM Spider-VCS Start Page		? ×
CRYSTAL Engineer	ing Data Managem	ent System
v		11.1.0.15
Recent tests		Account login
Open Test	Account Ad	Imin
	Password:	
		Please login to VCS.
	Keep me logged in	Login
Create a test		Spider connection status
Random	Spider-80X (SN: 2597504 (IP: 15	92.168.1.153)) detected.
Sine on Random Random on Random		
SROR Acoustic Control		
MIMO Random		
MESA RoRSoR MDOF Random		
Swept Sine		
Resonance search and tracked dwell Multi Sine Sine Oscillator, Sine Reduction		
Blade Fatique Test Resonance Search MIMO Sine MDOF Sine	Detect more Spiders	Do not show this start page
<u>Classical Shock</u>	A ST MA	
Transient Time History Control SRS Earthquake	New Edition	
Transient Random Sine Beat Seismic	Spider-80Xi With LCD	
Crash Control MIMO Shock MIMO TTH MIMO SRS	32/64 Channels Dynamic Data Ar	and the first of the first of the
Time waveform replication MIMO TWR		

The **New Test Wizard** will now open up. From here, select **Random** again and then press **Next**.

Finally, give the test a name and select the Spider system that will be used to run the test. Once all is complete, press **Create**.

# **Test Configuration**

The test will now need to be configured to run. This includes inputting information regarding the shaker, creating the schedule for the test to follow, and determining the parameters for the frequency analysis. To access the **Test Configuration** menu, press the **Config** button that can be found on the right side of the screen.

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#### **Shaker Parameters**

Click on **Edit Parameters** and enter the information from the shaker specifications. This is important for the safety of the shaker and testing unit.

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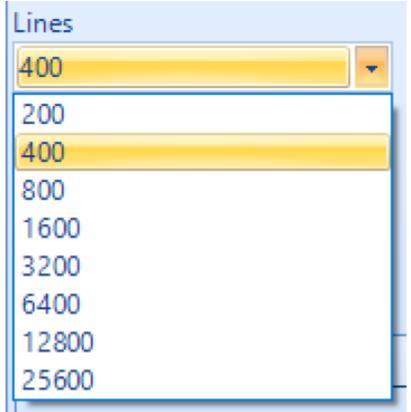
				? ×
haker details —				
Manufacturer	Anonymous		Shaker name Default Shaker	
orce and accele	eration —			
Random Max. Fo	orce RMS (LBF)	100.022 ≑	Random Max. Acc. RMS (g)	16.66667
Sine Max. Force	Peak (LBF)	2205.866	Sine Max. Acc. Peak (g)	75
Shock Max. Ford	e Peak (LBF)	100.022 ≑	Shock Max. Acc. Peak (g)	50
)isplacement —				
Max. positive dis	splacement (mm)	6.35	Max. negative displacement (mm)	6.35
ieneral settings				
Max. drive volta	ge peak (V)	10-	Max. velocity (m/s)	1.778
Min. drive frequ	ency (Hz)	1 🗮	Max. drive frequency (Hz)	2500
Shaker orientatio	on	Vertical 🔹		
haker moving r	mass			
Armature mass (	lb)	0.4409245	Header expander (lb) 🧵	0
Slip table (lb) 🖶	4	0 -	Drive bar (Ib) \leftrightarrow	0
Calc. acc. usi	na force			
	5	l in the shaker parameters page	Actual acceleration limits used in each te	st will be re-adjusted I
ollowing factor:				
		:/ (Armature mass + Payload ma t too high, the recommended rate	ass + other mass), Shaker param. acc.) ange within 10240 Hz.	
			-	

### **Test Parameters**

The **Test parameters** section in the **Test Configuration** window has settings for the analysis parameters, abort sensitivities and control strategy.

G Test Configurations for Random	Test [Random]							?	$\times$	
Test parameters «	Lines		DOF		Average		Overlap ratio			ī
Shaker parameters	400	-		0	Arcityc	60	50%		•	I
Test parameters	Delta frequency (Hz)	-	Control strategy		Sigma clipping		Drive limit (Volt Pk)			I
Pre-test parameters	5.000000	¥	Single channel	¥	adum cubburd	5 🛨	Dire min (von rig		-	L
Test profile		•	single channel	•		2		6		L
RMS limits	Frequency range (fa)(Hz)	_								I
Run schedule	Calculated by profile	*	Advanced settings							L
Limit channels										I
Event actions	Abort sensitivity			_						I
File directory		- (	•		Customize					I
Save/Recording setup	0.0	0	1.0							I
Output settings	Not sensitive		Very	sen	sitive					L
										L
	Low control RMS level		4	10.00	) dB					I
	Max RMS change			3.00						I
	Percent of lines past at			0.00	)%					I
	Displacement limit tole	rance	ratio 1	.50						L
	Summary									I
	Block T = 0.2 s		dT = 0.00019	5313	Is					I
	Sampling rate (fs) = 51	20.00	Hz Frequency rar	nae (	(fa) = 2000.00 Hz					L
	samping rate that the			900						I
										L
				_						L
										1
				:	2000.00 Hz					
Config. library 💌							QK	Can	cel	

Lines: The useful number of spectral lines, proportional to block size. Increasing the lines / block size will improve the resolution of the frequency spectrum (allowing better detection of lower frequencies) at the tradeoff of increased calculation time and slower response.

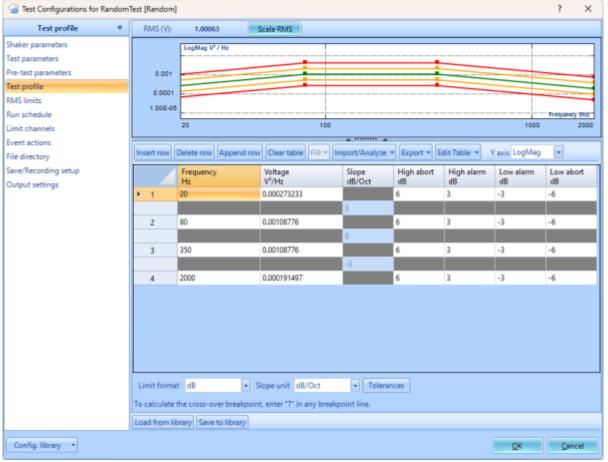


Control Strategy: Determines whether one or multiple control channels are used, and how the composite control signal is generated (if multiple channels are used).

C	Control strategy
	Single channel 🔹
	Single channel
	Weighted average
	Maximum
	Minimum

#### **Test Profile**

The test profile is defined in the Test Profile section of the Test Configuration window. A graphical preview of the profile plot is displayed above, with a breakpoint table below for entering the profile. CSV import / export is also supported as an alternative to profile editing.



Breakpoint Table: Breakpoints can be added via **Insert row**, **Delete row** and **Append row**. Use **Clear table** to clear out all rows except for the first and last row. Breakpoint Calculation: In the profile editor, EDM can calculate the crossover point given a specified slope and point value. If a '?' is entered as a Frequency or Amplitude value, EDM will interpolate that value given the slope before and after that point.

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nsert row Delete row Append row Clear table Fill V Import/Analyze V Export V Edit Table V axis LogMag V							
	Frequency Hz	Voltage V²/Hz	Slope dB/Oct	High abort dB	High alarm dB	Low alarm dB	Low abort dB
▶ 1	20	0.000273233		6	3	-3	-6
			3				
2	80	0.00108776		6	3	-3	-6
			0				
3	350	0.00108776		6	3	-3	-6
			-3				
4	2000	0.000191497		6	3	-3	-6

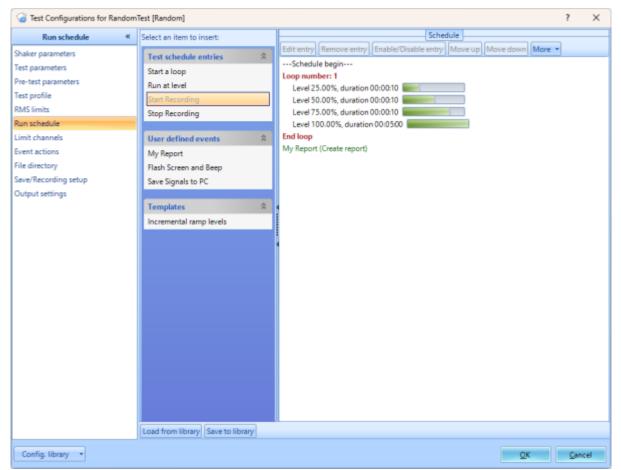
#### **RMS Limits**

The overall RMS level of the control channel(s) is monitored with alarm and abort limits. These limits are set under the **RMS Limits** section of the **Test Configuration** window. The table displays the expected RMS and peak values for the configured broadband profile, compared to the shaker limits as a percentage.

RMS limits					ay be significantly higher.		
haker parameters	Overall RMS includ profiles.	les narrowbands and s	sine tones that wi	Il be turned on in schedu	ule. Does not include all na	rrowbands and sine	tones
est parameters	Check AVD agains	t shahas Emilia					
re-test parameters	Check AVD agains	t snaker limits					
est profile	Physical quantity	Profile RMS	Profile expect values	ted Shaker limit	s Expected/Shake	er	
MS limits	Acceleration (g)	0.102	0.3061 (Peak)	50 (Peak)	0.6%		
in schedule	Velocity (m/s)	0.0008846	0.002654 (Peal		0.1%		
nit channels	Displacement (mn		0.01964 (Pk-Pi		0.2%		
ent actions	Force (LBF)	0.06749	0.2025 (Peak)	100 (RMS)	0.1%		
e directory	in the (the )		one and of the easy	ree (runa)			
ve/Recording setup							
	© Enter manually (	~~!					
		(a)		(dB)	(%)		
	High abort	(g)	(+)	(dB)	(%)		
	High abort	0.2036 +	(+)	6.00 ×	199.5 🛖		
	High alarm	0.2036 + 0.1441 +	(+) (+)				
		0.2036 +		6.00 ×	199.5 🛖		
	High alarm	0.2036 + 0.1441 +		6.00 ×	199.5 🛖		
	High alarm Profile RMS	0.2036 + 0.1441 + 0.102	(+)	6.00 + 3.00 +	1995 <del>*</del> 1413 <del>*</del>		
	High alarm Profile RMS	0.2036 + 0.1441 + 0.102	(+)	6.00 + 3.00 +	1995 <del>*</del> 1413 <del>*</del>		

#### **Run Schedule**

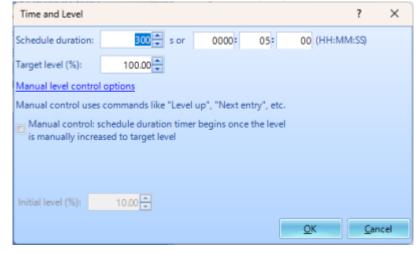
The **Run Schedule** defines how the test is run automatically through a preset routine. This schedule can support loops and periods of running at a specified level and duration. The **Run Schedule** can also include user-defined events in **Event Action Rules**.



Start a loop: Adds a new loop to the schedule – EDM will open a prompt for how many times to loop. Double-click on an existing loop number to edit the number of times for that entry.

Loop Times		x
Loop times:	2 🗘 🗙	
Note: Define t want to execu	the number of loop .te.	s that you
	<u>о</u> к	<u>C</u> ancel

Run at Level: Adds a new entry to run the test profile at a specified level. Schedule duration must be specified, as well as level as a percentage or dB of the target profile.



### **Input Channels**

### Channel Type

**Control** vs. **Monitor**. When running a test, there will need to be at least one control sensor. The control sensor is used to monitor the actual vibration levels that the shaker is producing. It then sends this data to the controller so that it maintains the targeted profile. This sensor should be mounted somewhere on the shaker/slip table itself, not the Device Under Test (DUT). Monitor sensors will show the levels that the DUT itself is experiencing.

#### **Measurement Quantity**

Defines the physical unit that will be measured by the sensor connected to the channel. **Sensitivity** 

Sets the proportionality factor for the measurement (millivolts per engineering unit) given as a parameter of the sensor.

#### Input Mode

There are five modes in which the inputs can operate:

*DC-Differential-* In the DC-Differential mode, neither of the input connections is referenced to the local ground. The input is taken as the potential difference between the two input terminals, and any potential in common with both terminals is canceled out. The Common Mode Voltage (CMV) will be rejected as long as the overall input voltage level does not saturate the input gain stage. Beware that very high CMV will cause clipping and may damage the input circuitry. Signals with a nonzero mean (DC component) can be measured in this mode.

*DC-Single End-* In single-ended mode, one of the input terminals is grounded and the input is taken as the potential difference of the center terminal with respect to this ground. Use this mode when the input needs to be grounded to reduce EMI noise or static buildup. Do not use this mode when the signal source is ground referenced or ground loop interference may result. This mode also allows signals with a non-zero mean to be measured.

*AC-Differential-* AC-Differential is a differential input mode that applies a low-frequency high-pass (DCblocking) analog filter to the input. It rejects common mode signals and DC components in the input signal. Use this when DC and low-frequency AC voltage measurements are not required or when a DC bias voltage is present. The analog high-pass filter has a cutoff frequency of -3dB at 0.3 Hz, and -0.1dB at 0.7 Hz for the IEPE input mode.

AC-Single End- AC-Single End grounds one of the input terminals and enables the DC-blocking analog filter. Use this mode for non-ground referenced sources where measuring the DC or low-frequency components are not required. It shares the same high-pass filter as that of AC-Differential.

*IEPE (ICP)*- All Crystal Instruments products support IEPE (Integral Electronic PiezoElectric) constant current output type input channels. IEPE refers to a class of transducers that are packaged with built-in voltage amplifiers powered by a constant current. These circuits are powered by a 4 mA constant current source at roughly 21 Volts.

## **Running the Test**

Now that all of the parameters for the test have been setup, the test is ready to run. Here are the final steps to start the test.

- 1. Press the **Connect** button to connect to the controller.
- 2. Press the **Run** button.
- 3. The **Spider Check List** will now appear. Here you can check the settings of the test and verify that all is set up properly. Press **Start** once this has been verified.
- 4. The Pre-Test will now begin. This will verify that the control loop is properly established and provide data that the control loop needs.
- 5. The test is now running

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